

EpiNet is LayTec's control and analysis software for EpiTT, EpiCurve® TT and Pyro 400 products. With EpiNet LayTec provides a user-friendly software tool with outstanding monitoring and diagnostic capabilities. Two different packages are available: Basic and Premium, depending on customer needs.

## **Features**

#### Measurements

- Measurement of emissivity corrected pyrometry, multi wavelength reflectometry and wafer curvature. Asphericity can be measured when using EpiCurve® TT AR (Advanced Resolution)
- Full linescan capabilities included (available during run and post run)
- Display of measurements as time resolved datasets, linescans and pseudo-3D color plot

#### **Data handling**

- Full integration of Pyro 400 and VCSEL-Add-On (spectral measurements)
- Storage of evaluated temperature and curvature data in a MS SQL data base
- Run Type management for easy repetition of identical or similar runs
- Storage and post-growth recalculation of measured raw data

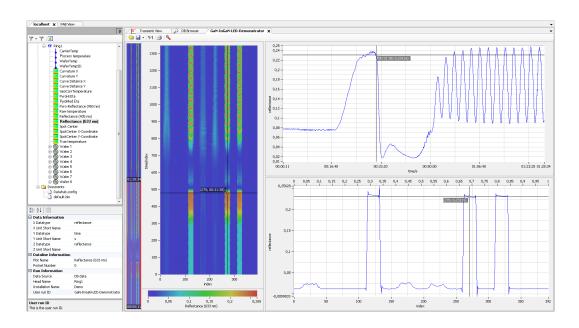
#### **Advanced analysis**

- Analysis recipe for synchronized step-by-step analysis for the growth process
- Fast determination of growth rate, layer thickness, and optical constants even for very thin layer
- Composition analysis of AlGaAs and AlInGaP
- Statistical analysis: average, maximum, minimum and standard deviation determination of slope (e.g. temperature, curvature...)
- Calculation of oscillation period and number of oscillations
- In-spec / out-of-control-limits / out-of-spec evaluation for all analysis results for all analysis steps
- Data processing of the measured data such as noise reduction, drift compensation, spike removal, shifting and scaling
- VCSEL DBR and special GaN/ Si related analyses

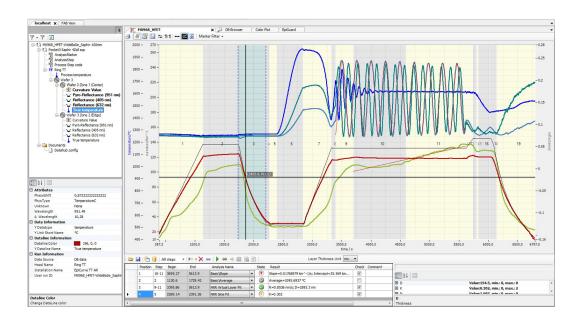
#### **Further features**

- EpiCurve® TT or EpiTT and Pyro 400 integration in one single computer
- Easy-to-use AbsoluT calibration display for temperature calibration
- Windows 10 64bit compatibility

## **Color plot**



## **Expert analysis**



# EpiNet licence package

- Basic / OEM package for basic operation and data analysis
- Premium package for advanced analysis and process understanding
- Additional licences for specific features

For more information about licence packages please contact <a href="mailto:sales@laytec.de">sales@laytec.de</a>.

Hardware requirements

EpiNet is developed to support LayTec's current line of metrology systems: EpiTT, EpiCurve®

TT, Pyro 400 and similar systems.

**Office Environment** 

EpiNet is compatible to most Windows 7, 10 and 11 computers. It is recommended to use Windows 10 64bit and a 21+ inch monitor.

Measurement Environment EpiNet is developed and tested within a certain hardware and software setup due to hardware timings and driver compatibility. EpiNet is actively developed solely on the current and therefore recommended measurement PC setups.

Standard Setup\*

- Mainboard: Supermicro X11SSH-LN4FRAM: 16GB ECC DDR4 RAM or more
- CPU: Intel Core i3-7100 or better (Intel Core-i3/ Intel XEON-E3 CPUs)
- SSD with 1TB or better
- Chassis: 1HE

Upgrade and Replacement Setup for older Systems Mainboard: Advantech AIMB-786RAM: 8GB DDR4 RAM or moreCPU: Intel Core i3-7100 or better

- SSD with 500GB or better

- Chassis: 4HE

**Upgrade Paths\*** 

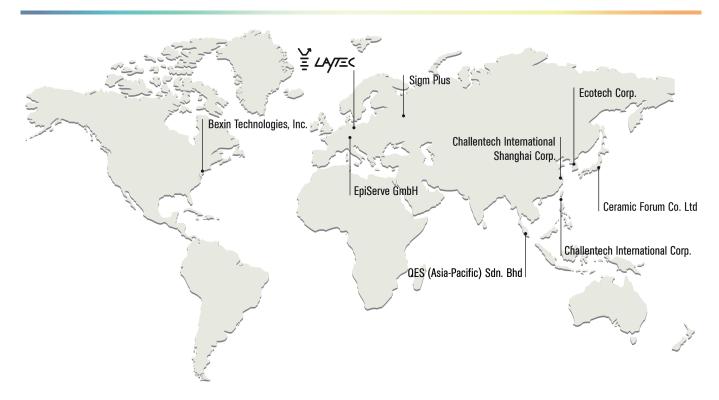
Systems from 2015 and above generally support Windows 10 64bit and the newest EpiNet version. We recommand an "SSD upgrade" containing a pre-configured setup for easy integration and minimal downtime.

Due to Windows 10 CPU restrictions systems from before 2015 will most likley need a hardware upgrade. Please contact our sales team directly for more information.

\* Please keep in mind that LayTec will not take responsibility for data loss and/or damage to software or hardware in case of customer changes to the system. This includes settings and additional applications. Profound changes would be: changing BIOS settings or installing introusive software like virus scanners. Please ask our customer support if a specific action is applicable. Measurement systems are not designed for Internet access!

Perform regular data backups to counter data loss.

## **Global Network**



We are the leading manufacturer of integrated optical metrology systems for all thin-film processes. LayTec systems can be customized for every specific process. For your specific application please contact LayTec directly or your local LayTec representative:

Challentech International (Shanghai) Corp.\* Challentech International Corp.\*

**CHINA** 

www.challentech.com.cn

Bexin Technologies Inc.

(for MBE metrology systems)

**NORTH AMERICA** 

Ceramic Forum Co. Ltd.\*

**JAPAN** 

www.ceramicforum.co.jp/en.html

\* provide technical service as well

TAIWAN R.O.C.

www.challentech.com.tw

Sigm Plus\*

(inactive due to current export

regulations)

**RUSSIA** 

www.siplus.ru

QES (Asia-Pacific) Sdn. Bhd\*

MALAYSIA

www.qesnet.com

Ecotech Corp.\* REPUBLIC OF KOREA

EpiServe GmbH

(for MBE metrology systems)

**GERMANY** 

www.episerve.de

Specifications are subject to further technical development and may differ from those given in the data sheet. In certain cases, performance may be limited by reactor type and/or growth conditions. Please consult our technical sales team to see how LayTec metrology can best serve your specific application.

For further information please contact:

LayTec AG Seesener Str. 10-13 10709 Berlin, Germany Tel.: +49 (0)30 89 00 55-0 Fax: +49 (0)30 89 00 55-180 Email: info@laytec.de

Web: laytec.de

MEMBER OF THE NYNOMIC GROUP

Developed, manufactured and qualified in Germany.

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